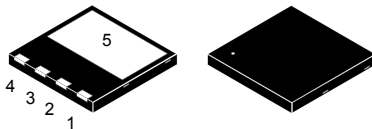
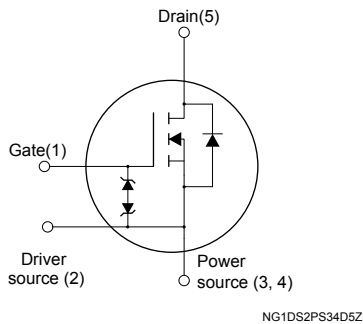


## N-channel 600 V, 0.184 $\Omega$ typ., 16 A MDmesh™ M2 EP Power MOSFET in a PowerFLAT™ 8x8 HV package



PowerFLAT™ 8x8 HV



### Features

| Order code    | $V_{DS} @ T_{Jmax}$ | $R_{DS(on)}$ max. | $I_D$ |
|---------------|---------------------|-------------------|-------|
| STL25N60M2-EP | 650 V               | 0.205 $\Omega$    | 16 A  |

- Extremely low gate charge
- Excellent output capacitance ( $C_{OSS}$ ) profile
- Very low turn-off switching losses
- 100% avalanche tested
- Zener-protected

### Applications

- Switching applications
- Tailored for Very High Frequency Converters ( $f > 150$  kHz)

### Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 EP enhanced performance technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance, optimized switching characteristics with very low turn-off switching losses, rendering it suitable for the most demanding very high frequency converters.

#### Product status

STL25N60M2-EP

#### Device summary

|                   |                   |
|-------------------|-------------------|
| <b>Order code</b> | STL25N60M2-EP     |
| <b>Marking</b>    | 25N60M2EP         |
| <b>Package</b>    | PowerFLAT™ 8x8 HV |
| <b>Packing</b>    | Tape and reel     |

# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

| Symbol         | Parameter   | Value       | Unit             |
|----------------|---|-------------|------------------|
| $V_{GS}$       | Gate-source voltage   | $\pm 25$    | V                |
| $I_D$          | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$  | 16          | A                |
| $I_D$          | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 10          | A                |
| $I_{DM}^{(1)}$ | Drain current (pulsed)  | 64          | A                |
| $P_{TOT}$      | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$           | 125         | W                |
| $dv/dt^{(2)}$  | Peak diode recovery voltage slope                               | 15          | V/ns             |
| $dv/dt^{(3)}$  | MOSFET $dv/dt$ ruggedness                                       | 50          | V/ns             |
| $T_{stg}$      | Storage temperature range                                       | - 55 to 150 | $^\circ\text{C}$ |
| $T_j$          | Operating junction temperature range                            |             |                  |

1. Pulse width limited by safe operating area.
2.  $I_{SD} \leq 16\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ;  $V_{DS(peak)} < V_{(BR)DSS}$ ,  $V_{DD} = 400\text{ V}$ .
3.  $V_{DS} \leq 480\text{ V}$

**Table 2. Thermal data**

| Symbol              | Parameter                        | Value | Unit                      |
|---------------------|----------------------------------|-------|---------------------------|
| $R_{thj-case}$      | Thermal resistance junction-case | 1     | $^\circ\text{C}/\text{W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb  | 45    | $^\circ\text{C}/\text{W}$ |

1. When mounted on FR-4 board of  $inch^2$ , 2oz Cu.

**Table 3. Avalanche characteristics**

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )                                 | 3.5   | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ ; $V_{DD} = 50\text{ V}$ ) | 180   | mJ   |

## 2 Electrical characteristics

$T_C = 25\text{ }^\circ\text{C}$  unless otherwise specified

**Table 4. On/off states**

| Symbol        | Parameter                         | Test conditions   | Min. | Typ.  | Max.     | Unit          |
|---------------|-----------------------------------|---|------|-------|----------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage    | $V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$  | 600  |       |          | V             |
| $I_{DSS}$     | Zero gate voltage drain current   | $V_{GS} = 0\text{ V}, V_{DS} = 600\text{ V}$  |      |       | 1        | $\mu\text{A}$ |
|               |                                   | $V_{GS} = 0\text{ V}, V_{DS} = 600\text{ V}, T_C = 125\text{ }^\circ\text{C}^{(1)}$ |      |       | 100      | $\mu\text{A}$ |
| $I_{GSS}$     | Gate-body leakage current         | $V_{DS} = 0\text{ V}, V_{GS} = \pm 25\text{ V}$                                     |      |       | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(th)}$  | Gate threshold voltage            | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$                                     | 3.25 | 4     | 4.75     | V             |
| $R_{DS(on)}$  | Static drain-source on-resistance | $V_{GS} = 10\text{ V}, I_D = 8\text{ A}$  |      | 0.184 | 0.205    | $\Omega$      |

1. Defined by design, not subject to production test.

**Table 5. Dynamic**

| Symbol                     | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit     |
|----------------------------|-------------------------------|---|------|------|------|----------|
| $C_{iss}$                  | Input capacitance             | $V_{DS} = 100\text{ V}, f = 1\text{ MHz}, V_{GS} = 0\text{ V}$  | -    | 1090 | -    | pF       |
| $C_{oss}$                  | Output capacitance            |   | -    | 56   | -    | pF       |
| $C_{rss}$                  | Reverse transfer capacitance  |   | -    | 1.6  | -    | pF       |
| $C_{oss\text{ eq.}}^{(1)}$ | Equivalent output capacitance | $V_{DS} = 0\text{ to }480\text{ V}, V_{GS} = 0\text{ V}$  | -    | 255  | -    | pF       |
| $R_G$                      | Intrinsic gate resistance     | $f = 1\text{ MHz}, I_D = 0\text{ A}$  | -    | 7    | -    | $\Omega$ |
| $Q_g$                      | Total gate charge             | $V_{DD} = 480\text{ V}, I_D = 18\text{ A}, V_{GS} = 0\text{ to }10\text{ V}$ (see <a href="#">Figure 15. Gate charge test circuit</a> ) | -    | 29   | -    | nC       |
| $Q_{gs}$                   | Gate-source charge            |   | -    | 6    | -    | nC       |
| $Q_{gd}$                   | Gate-drain charge             |   | -    | 12   | -    | nC       |

1.  $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 6. Switching Energy**

| Symbol      | Parameter  | Test conditions  | Min. | Typ. | Max. | Unit          |
|-------------|--|--|------|------|------|---------------|
| $E_{(off)}$ | Turn-off energy (from 90% $V_{GS}$ to 0% $I_D$ ) | $V_{DD} = 400\text{ V}, I_D = 2\text{ A}, R_G = 4.7\text{ }\Omega, V_{GS} = 10\text{ V}$ | -    | 7    | -    | $\mu\text{J}$ |
|             |  | $V_{DD} = 400\text{ V}, I_D = 4\text{ A}, R_G = 4.7\text{ }\Omega, V_{GS} = 10\text{ V}$ | -    | 8    | -    | $\mu\text{J}$ |

**Table 7. Switching times**

| Symbol       | Parameter           | Test conditions   | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 300\text{ V}$ , $I_D = 9\text{ A}$<br>$R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$<br>(see Figure 14. Switching times test circuit for resistive load and Figure 19. Switching time waveform) | -    | 15   | -    | ns   |
| $t_r$        | Rise time           |   | -    | 10   | -    | ns   |
| $t_{d(off)}$ | Turn-off-delay time |   | -    | 61   | -    | ns   |
| $t_f$        | Fall time           |   | -    | 16   | -    | ns   |

**Table 8. Source drain diode**

| Symbol          | Parameter                     | Test conditions  | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|--|------|------|------|---------------|
| $I_{SD}$        | Source-drain current          |  | -    |      | 16   | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |  | -    |      | 64   | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $V_{GS} = 0\text{ V}$ , $I_{SD} = 16\text{ A}$   | -    |      | 1.6  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 18\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 100\text{ V}$ (see Figure 16. Test circuit for inductive load switching and diode recovery times)   | -    | 360  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |  | -    | 5    |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |  | -    | 28   |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 18\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 100\text{ V}$ , $T_j = 150\text{ }^\circ\text{C}$<br>(see Figure 16. Test circuit for inductive load switching and diode recovery times ) | -    | 445  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |  | -    | 6.5  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |  | -    | 29   |      | A             |

1. Pulse width is limited by safe operating area
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

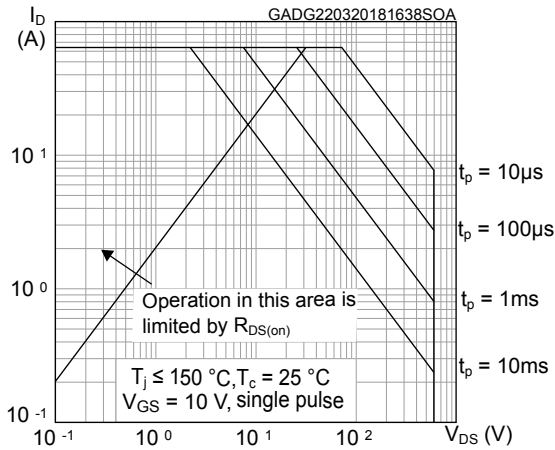


Figure 2. Thermal impedance

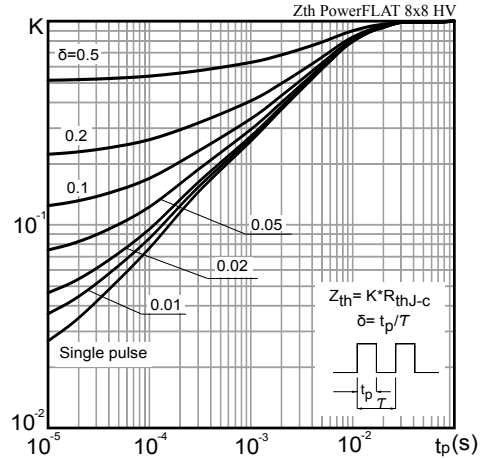


Figure 3. Output characteristics

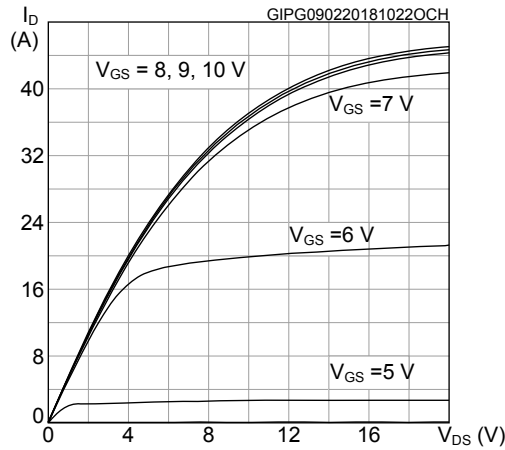


Figure 4. Transfer characteristics

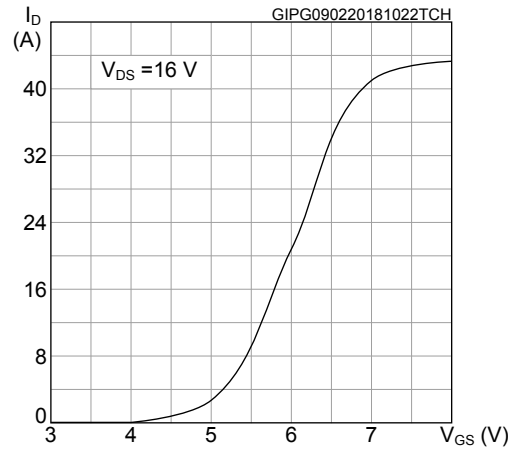


Figure 5. Gate charge vs gate-source voltage

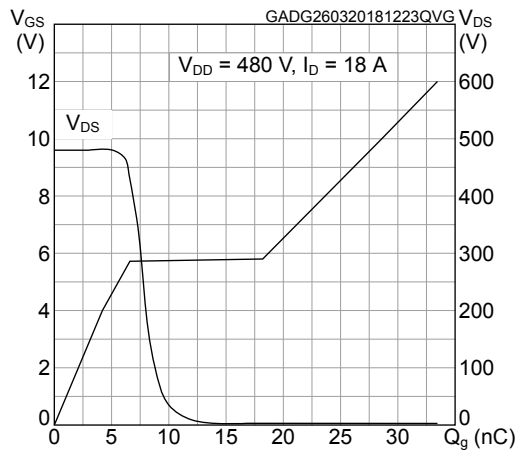


Figure 6. Static drain-source on-resistance

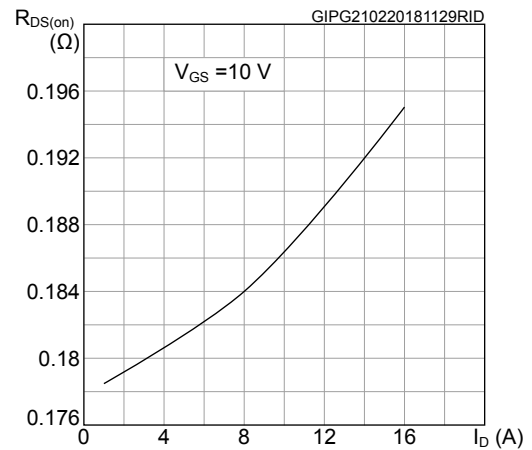


Figure 7. Capacitance variations

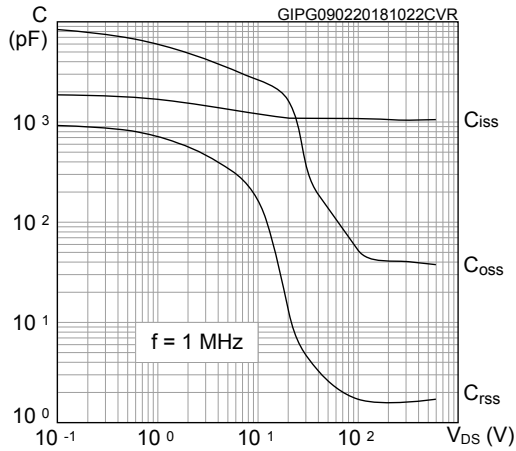


Figure 8. Output capacitance stored energy

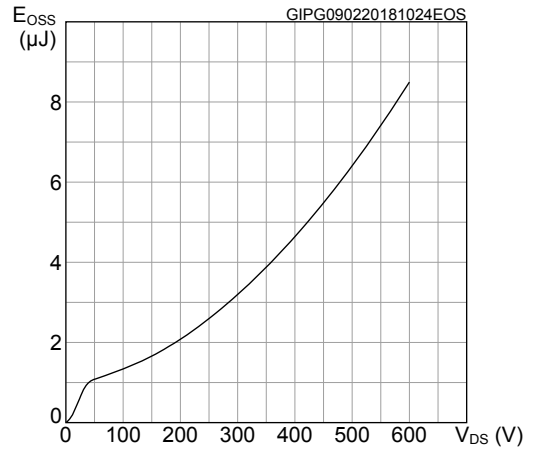


Figure 9. Turn-off switching energy vs drain current

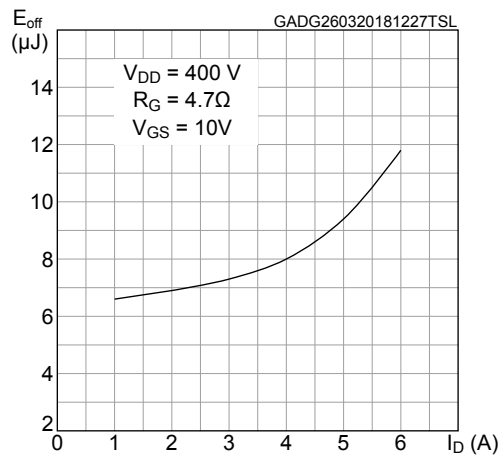


Figure 10. Normalized gate threshold voltage vs temperature

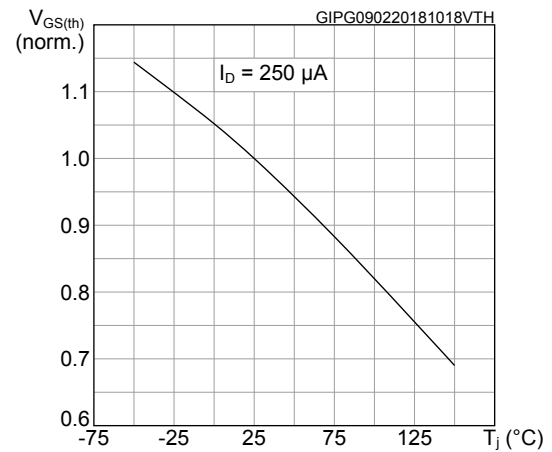


Figure 11. Normalized on-resistance vs temperature

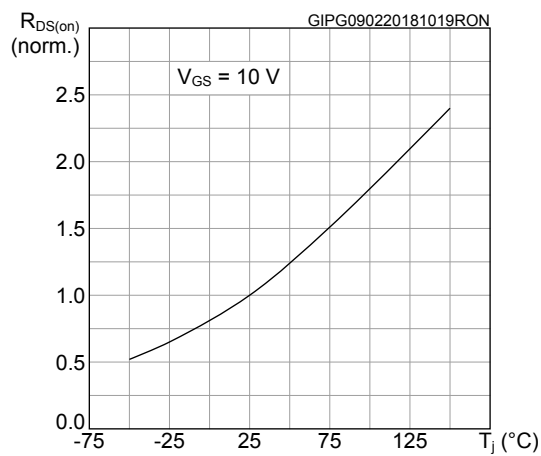


Figure 12. Normalized  $V_{(BR)DSS}$  vs temperature

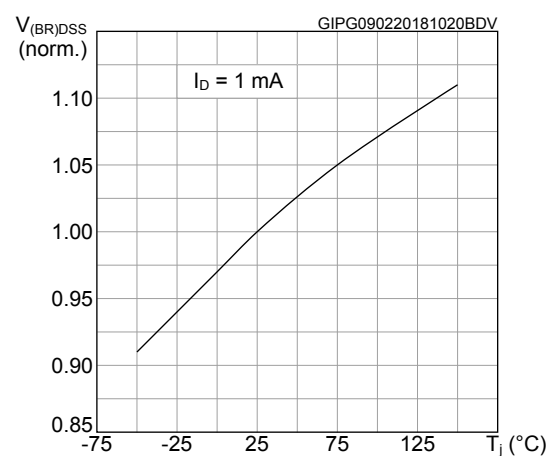
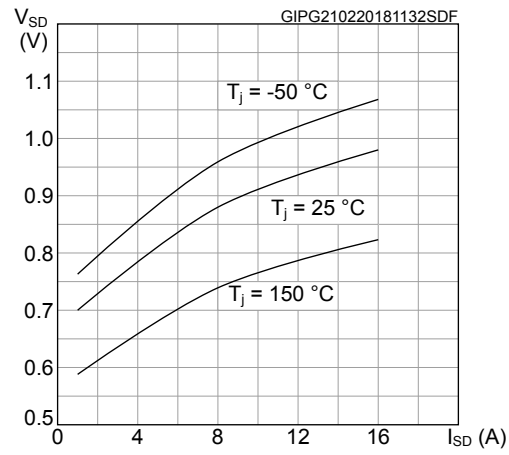
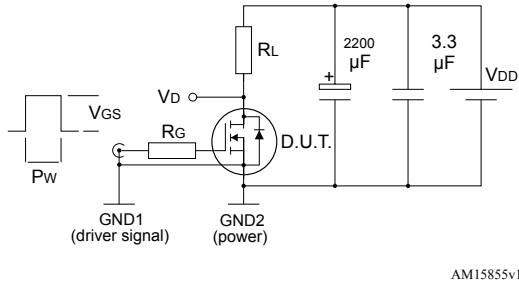


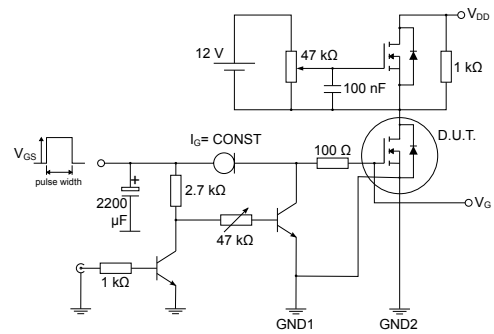
Figure 13. Source-drain diode forward characteristics



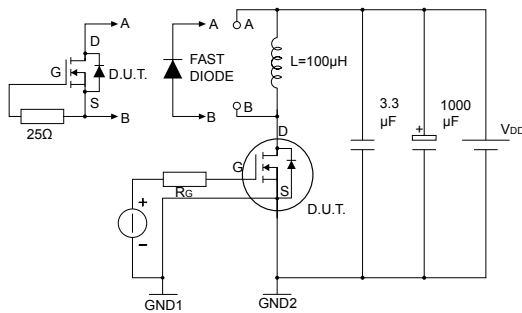
### 3 Test circuits

**Figure 14. Switching times test circuit for resistive load**


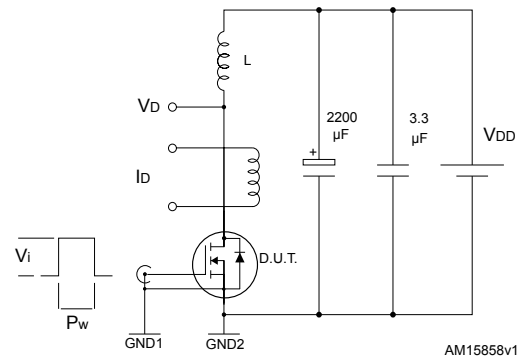
AM15855v1

**Figure 15. Gate charge test circuit**


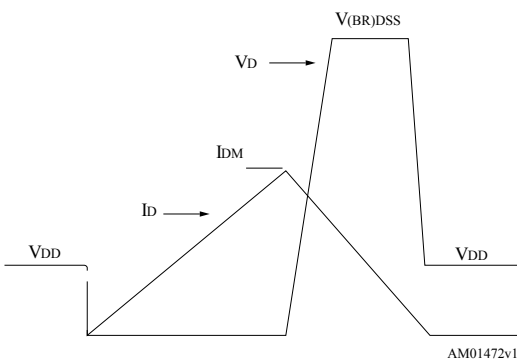
AM01469v2

**Figure 16. Test circuit for inductive load switching and diode recovery times**


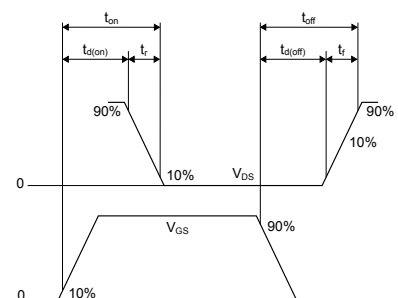
AM15857v1

**Figure 17. Unclamped inductive load test circuit**


AM15858v1

**Figure 18. Unclamped inductive waveform**


AM01472v1

**Figure 19. Switching time waveform**


AM01473v1



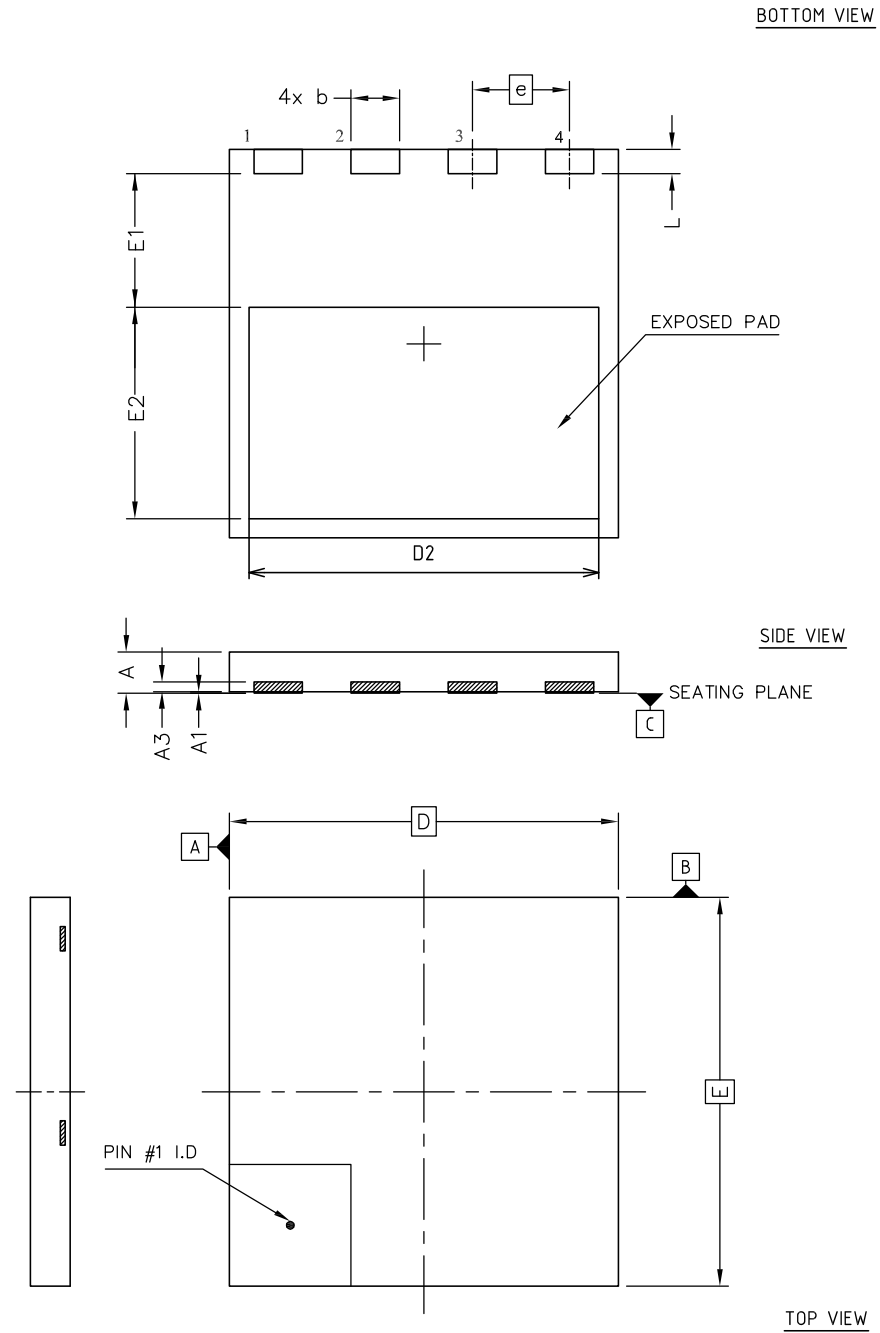
## 4 Package information

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In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

## 4.1 PowerFLAT™ 8x8 HV package information

Figure 20. PowerFLAT™ 8x8 HV package outline

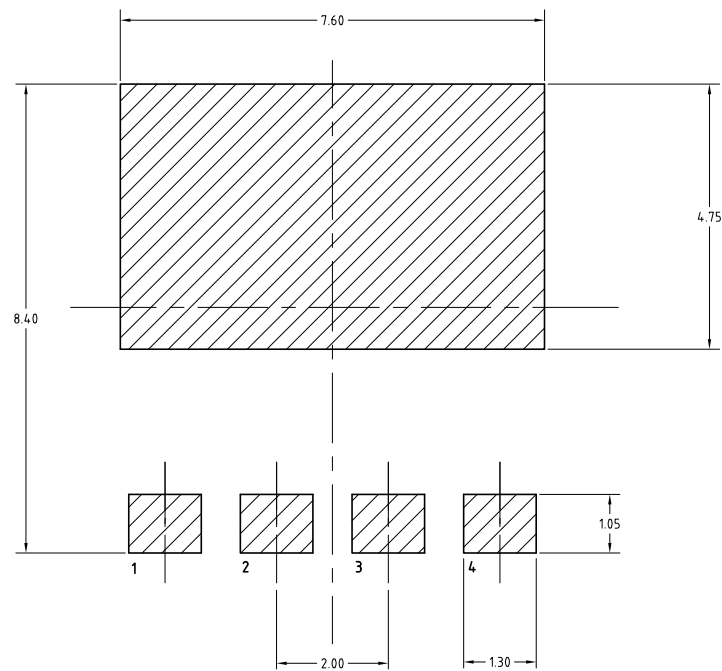


8222871\_Rev\_4

Table 9. PowerFLAT™ 8x8 HV mechanical data

| Dim. | mm       |      |      |
|------|----------|------|------|
|      | Min.     | Typ. | Max. |
| A    | 0.75     | 0.85 | 0.95 |
| A1   | 0.00     |      | 0.05 |
| A3   | 0.10     | 0.20 | 0.30 |
| b    | 0.90     | 1.00 | 1.10 |
| D    | 7.90     | 8.00 | 8.10 |
| E    | 7.90     | 8.00 | 8.10 |
| D2   | 7.10     | 7.20 | 7.30 |
| E1   | 2.65     | 2.75 | 2.85 |
| E2   | 4.25     | 4.35 | 4.45 |
| e    | 2.00 BSC |      |      |
| L    | 0.40     | 0.50 | 0.60 |

Figure 21. PowerFLAT™ 8x8 HV footprint

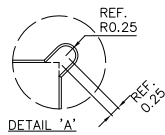
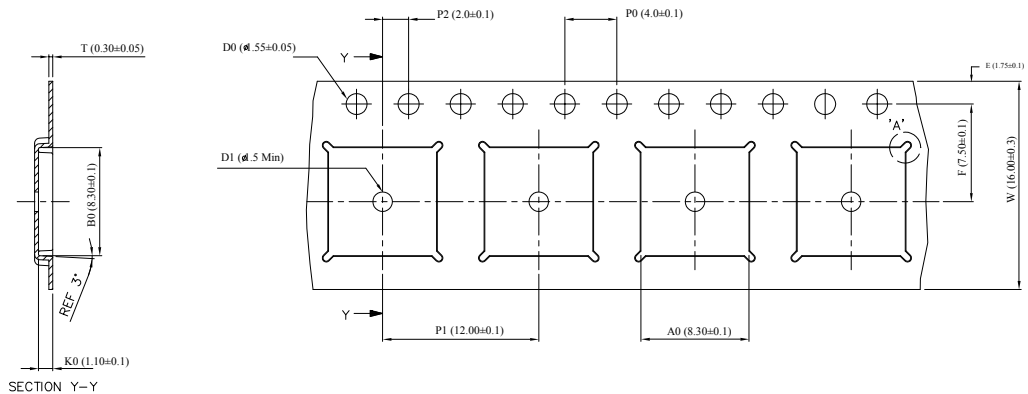


8222871\_REV\_4\_footprint

Note: All dimensions are in millimeters.

## 5 PowerFLAT™ 8x8 HV packing information

Figure 22. PowerFLAT™ 8x8 HV tape



Note: Base and Bulk quantity 3000 pcs

8229819\_Tape\_revA

Note: All dimensions are in millimeters.

Figure 23. PowerFLAT™ 8x8 HV package orientation in carrier tape

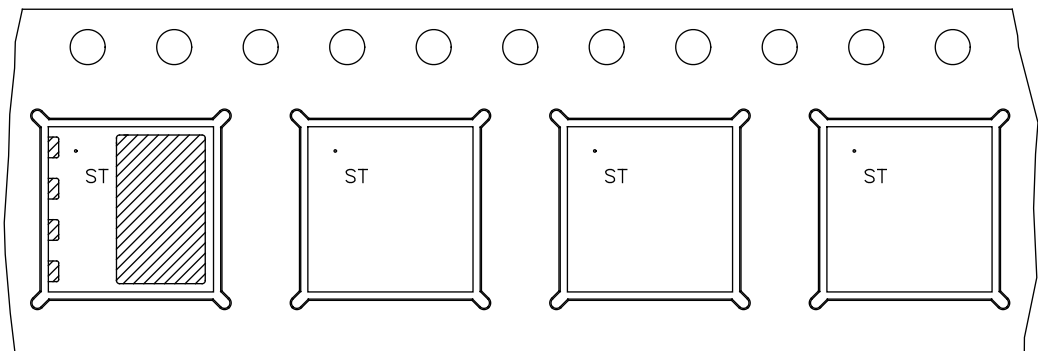
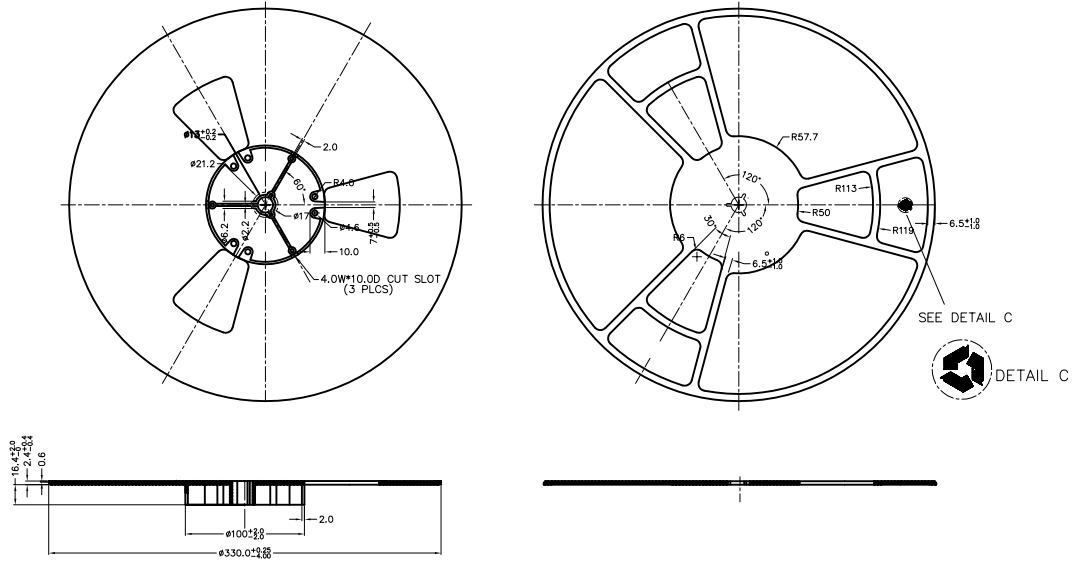


Figure 24. PowerFLAT™ 8x8 HV reel



8229819\_Reel\_revA

Note: All dimensions are in millimeters.

## Revision history

**Table 10. Document revision history**

| Date        | Revision | Changes   |
|-------------|----------|---|
| 02-Dec-2014 | 1        | First release.  |
| 12-Jan-2015 | 2        | Updated product status from "preliminary data" to "production data".  |
| 20-Nov-2015 | 3        | Updated: cover image and <i>Figure 1: "Internal schematic diagram"</i><br>Updated: <i>Section 3: "Test circuits"</i><br>Modified: <i>Section 4.1: "PowerFLAT 8x8 HV package information"</i><br>Minor text changes  |
| 21-Feb-2018 | 4        | Removed maturity status indication from cover page. The document status is production data.<br>Modified <i>Table 1. Absolute maximum ratings, Table 4. On/off states, Table 5. Dynamic, Table 6. Switching Energy, Table 7. Switching times and Table 8. Source drain diode.</i><br>Modified the entire <i>Section 2.1 Electrical characteristics (curves)</i> .<br>Minor text changes. |
| 26-Mar-2018 | 5        | Modified <i>Table 1. Absolute maximum ratings, Table 4. On/off states, Table 5. Dynamic, Table 6. Switching Energy, Table 7. Switching times, Table 8. Source drain diode and Section 2.1 Electrical characteristics (curves)</i> .<br>Minor text changes.  |

## Contents

|            |  |           |
|------------|--|-----------|
| <b>1</b>   | <b>Electrical ratings</b> .....                    | <b>2</b>  |
| <b>2</b>   | <b>Electrical characteristics</b> .....            | <b>3</b>  |
| <b>2.1</b> | <b>Electrical characteristics (curves)</b> .....   | <b>5</b>  |
| <b>3</b>   | <b>Test circuits</b> .....                         | <b>8</b>  |
| <b>4</b>   | <b>Package information</b> .....                   | <b>9</b>  |
| <b>4.1</b> | <b>PowerFLAT™ 8x8 HV package information</b> ..... | <b>9</b>  |
| <b>5</b>   | <b>PowerFLAT™ 8x8 HV packing information</b> ..... | <b>12</b> |
|            | <b>Revision history</b> .....                      | <b>14</b> |
|            | <b>Contents</b> .....                              | <b>15</b> |
|            | <b>Disclaimer</b> .....                            | <b>16</b> |

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[SSM6P69NU,LF](#) [DMP22D4UFO-7B](#) [DMN1006UCA6-7](#)